

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/790,049	SASAKI ET AL.	
Examiner		Art Unit		Page 1 of 1
A. Dexter Tugbang		3729		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,254,374	10-1993	Devlin et al.	427/255.28 x
*	B	US-5,626,922	05-1997	Miyanaga et al.	427/585 X
*	C	US-5,763,021	06-1998	Young et al.	427/585 x
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2-308533	12-1990	Japan	Kato et al	204/192.1
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Xie et al., "MR Sensor Oxidation Mechanism at High Temperature", IEEE Transactions on Magnetics, Vol. 35, No. 5, pages 2619-2621, September 1999.
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.